

## **MOSFET** - Single N-Channel 150 V, 4.4 mΩ, 187 A

# **NVBLS4D0N15MC**

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parameter			Value	Unit
V <sub>DSS</sub>	Drain-to-Source Voltage			150	V
$V_{GS}$	Gate-to-Source Voltag	e		±20	V
I <sub>D</sub>	Continuous Drain	Steady State	T <sub>C</sub> = 25°C	187	Α
	Current R <sub>0JC</sub> (Note 2)	State	T <sub>C</sub> = 100°C	132	
P <sub>D</sub>	Power Dissipation	Steady State	T <sub>C</sub> = 25°C	316	W
	R <sub>θJC</sub> (Note 2)	State	T <sub>C</sub> = 100°C	158	
I <sub>D</sub>	Continuous Drain	Steady State	T <sub>A</sub> = 25°C	22	Α
	Current R <sub>θJA</sub> (Notes 1, 2)	State	T <sub>A</sub> = 100°C	15	
P <sub>D</sub>	Power Dissipation	Steady	T <sub>A</sub> = 25°C	4	W
	R <sub>θJA</sub> (Notes 1, 2) State		T <sub>A</sub> = 100°C	2	
I <sub>DM</sub>	Pulsed Drain Current	T <sub>A</sub> = 25°C	C, t <sub>p</sub> = 10 μs	900	Α
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range			-55 to +175	°C
I <sub>S</sub>	Source Current (Body Diode)			263	Α
E <sub>AS</sub>	Single Pulse Drain-to-Source Avalanche Energy (I <sub>LPEAK</sub> = 15.9 A)			2300	mJ
TL	Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

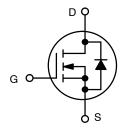
- 1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 2 oz Cu pad.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

#### THERMAL RESISTANCE RATINGS

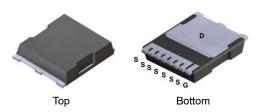
Symbol	Parameter		Unit
$R_{\theta JC}$	Junction-to-Case - Steady State (Note 2)	0.5	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 2)	35.8	

1

V <sub>(BR)DSS</sub>	(BR)DSS R <sub>DS(ON)</sub> MAX	
150 V	4.4 m $\Omega$ @ 10 V	187 A

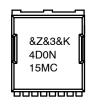


**N-CHANNEL MOSFET** 



H-PSOF8L 11.68x9.80 MO-299A CASE 100CU

#### **MARKING DIAGRAM**



&Z = Assembly Plant Code &3 = Numeric Date Code

&K = Lot Code

4D0N15MC = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVBLS4D0N15MC	MO-299A (Pb-Free)	2000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test C	ondition	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS	•		•	•		
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		150	_	-	V
V <sub>(BR)DSS</sub> / T <sub>J</sub>	Drain-to-Source Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, ref to 25°C		_	30.23	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0 V,$	T <sub>J</sub> = 25°C	-	_	1	μΑ
		V <sub>DS</sub> = 120 V	T <sub>J</sub> = 125°C	-	-	10	μΑ
I <sub>GSS</sub>	Gate-to-Source Leakage Current	$V_{DS} = 0 V, V_{GS}$	= ±20 V	_	_	±100	nA
ON CHARACTE	ERISTICS						
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =	= 584 μΑ	2.5	3.7	4.5	V
V <sub>GS(TH)</sub> / T <sub>J</sub>	Negative Threshold Temperature Coefficient	I <sub>D</sub> = 250 μA, re	f to 25°C	_	-10.12	-	mV/°C
R <sub>DS(on)</sub>	Drain-to-Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub>	= 80 A	_	3.1	4.4	mΩ
9FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_D =$	80 A	_	174	-	S
$R_{G}$	Gate-Resistance	T <sub>A</sub> = 25°C		-	1.3	-	Ω
CHARGES & C	APACITANCES	•			•		
C <sub>ISS</sub>	Input Capacitance	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 75 V		-	7490	-	pF
C <sub>OSS</sub>	Output Capacitance			-	2055	-	1
C <sub>RSS</sub>	Reverse Transfer Capacitance			_	27.2	-	
Q <sub>G(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 75 V,		_	90.4	-	nC
Q <sub>G(TH)</sub>	Threshold Gate Charge	I <sub>D</sub> = 80 A		_	24.7	-	1
Q <sub>GS</sub>	Gate-to-Source Charge	- - -		_	40.2	-	1
$Q_{GD}$	Gate-to-Drain Charge			_	12.6	-	
$V_{GP}$	Plateau Voltage			_	5.7	-	V
SWITCHING CH	HARACTERISTICS, V <sub>GS</sub> = 10 V (Note 3)						
t <sub>d(ON)</sub>	Turn-On Delay Time	V <sub>GS</sub> = 10 V, V <sub>D</sub>	<sub>S</sub> =75 V,	_	47	-	ns
t <sub>r</sub>	Rise Time	I <sub>D</sub> = 80 A, R <sub>G</sub> =	6 Ω	_	115	-	
t <sub>d(OFF)</sub>	Turn-Off Delay Time			_	58	-	
t <sub>f</sub>	Fall Time	1		_	11	-	
DRAIN-SOURC	CE DIODE CHARACTERISTICS						
V <sub>SD</sub>	Forward Diode Voltage	$V_{GS} = 0 V$	T <sub>J</sub> = 25°C	_	0.86	1.2	V
		I <sub>S</sub> = 80 A	T <sub>J</sub> = 125°C	-	0.75	-	
t <sub>RR</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } dI_{S}$	dt = 100 A/μs,	_	84	-	ns
ta	Charge Time	I <sub>S</sub> = 80 A		_	55	-	1
t <sub>b</sub>	Discharge Time			_	29	-	1
Q <sub>RR</sub>	Reverse Recovery Charge			_	180	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

#### **TYPICAL CHARACTERISTICS**

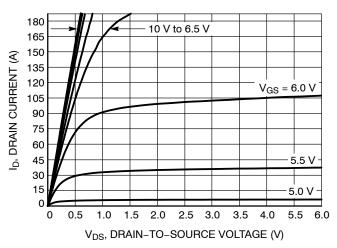


Figure 1. On-Region Characteristics

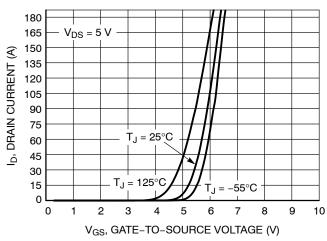


Figure 2. Transfer Characteristics

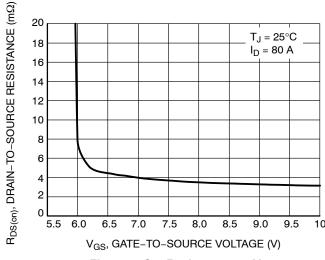


Figure 3. On-Resistance vs. V<sub>GS</sub>

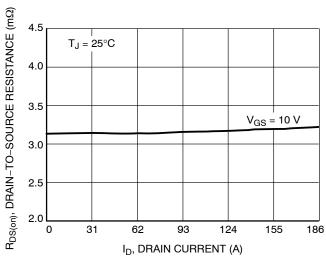


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

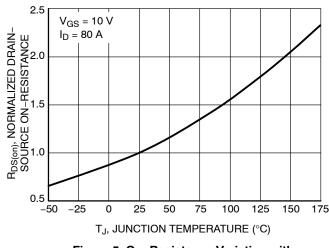


Figure 5. On–Resistance Variation with Temperature

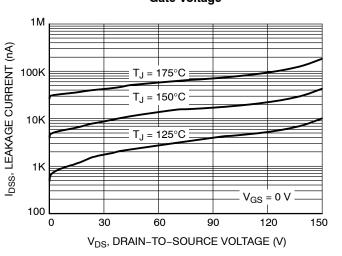


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

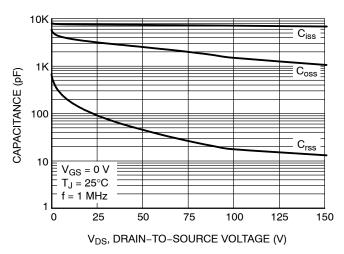


Figure 7. Capacitance Variation

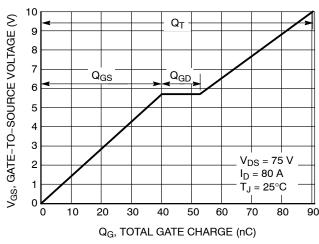


Figure 8. Gate-to-Source Voltage vs. Total Gate Charge

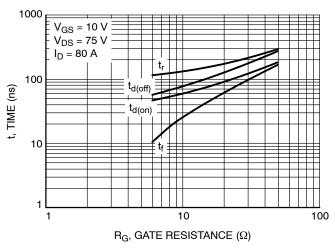


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

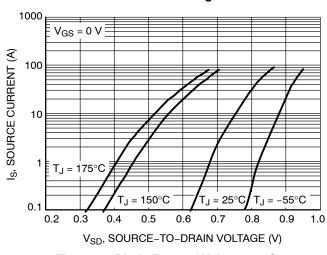


Figure 10. Diode Forward Voltage vs. Current

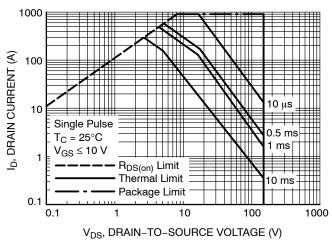


Figure 11. Maximum Rated Forward Biased Safe Operating Area

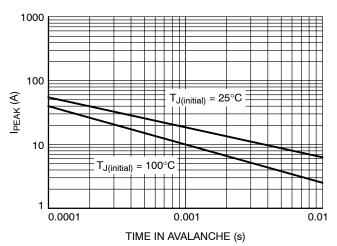


Figure 12.  $I_{\mbox{\scriptsize PEAK}}$  vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

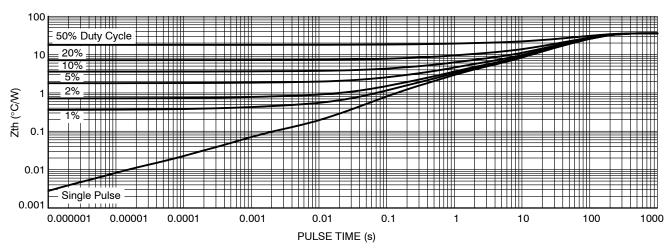


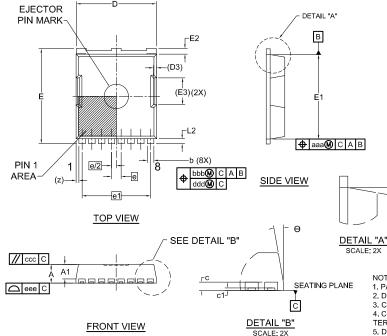
Figure 13. Thermal Characteristics (Junction-to-Ambient)





#### H-PSOF8L 11.68x9.80 CASE 100CU **ISSUE B**

#### **DATE 20 MAY 2022**



5.10--4 45-2.95 8.10 4.99 2.04 2 90 13,28 1.46 0.60 0.86 2.80 1.20 0.80 Α

10.20

#### LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

#### NOTES:

- 1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE A.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009. 3. CONTROLLING DIMENSION: MILLIMETERS.
- 4. COPLANARITY APPLIES TO THE EXPOSED WELL AS THE TERMINALS.
- 5. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 6. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

AD1	Ф ааа (М С А В
1 8 1 8 1 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	11 +
——————————————————————————————————————	GENERIC MARKING DIAGRAM*  AYWWZZ  XXXXXXXX  XXXXXXXX

Α

WW

ZΖ

DIM	MILLIMETERS			
DIW	MIN.	NOM.	MAX.	
Α	2.20	2.30	2.40	
A1	1.70	1.80	1.90	
b	0.70	0.80	0.90	
b1		8.00 REF	:	
С	0.40	0.50	0.60	
c1	0.10			
D	9.70	9.80	9.90	
D1	9.80	9.90	10.00	
D2	4.73 BSC			
D3		0.40 REF	=	
D4	;	3.75 BSC	;	
D5		1.20		
D6	7.40	7.50	7.60	
D7		3.30 REF		
Е	11.58	11.68	11.78	
E1	10.28	10.38	10.48	
E2	0.60	0.70	0.80	
E3	3.30 REF			
E4		2.60		
E5	3.30			

DIM	MILLIMETERS			
DIW	MIN.	NOM.	MAX.	
E6	_	0.65		
E7		7.15 REF	:	
E8	6.55	6.65	6.75	
E9		5.89 BSC	)	
E10	5.19 BSC			
E11		0.10 REF	:	
е		1.20 BSC	;	
e/2		0.60 BSC	;	
e1	8.40 BSC			
K	2.43	2.53	2.63	
L	1.90	2.00	2.10	
L2	0.50	0.60	0.70	
z		0.35 REF	•	
θ	0° 12°			
aaa	0.20			
bbb	0.25			
ccc	0.20			
ddd	0.20			
eee	0.10			

= Assembly Location = Year = Work Week = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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XXXX = Specific Device Code

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